Accepted Manuscript

Thermal stability of nanoscale metallic multilayers

A.S. Ramos, A.J. Cavaleiro, M.T. Vieira, J. Morgiel, G. Safran

PII: S0040-6090(14)00640-3 DOI: doi: 10.1016/j.tsf.2014.05.065

Reference: TSF 33506

To appear in: Thin Solid Films

Received date: 19 December 2013 Revised date: 14 May 2014 Accepted date: 27 May 2014



Please cite this article as: A.S. Ramos, A.J. Cavaleiro, M.T. Vieira, J. Morgiel, G. Safran, Thermal stability of nanoscale metallic multilayers, *Thin Solid Films* (2014), doi: 10.1016/j.tsf. 2014.05.065

This is a PDF file of an unedited manuscript that has been accepted for publication. As a service to our customers we are providing this early version of the manuscript. The manuscript will undergo copyediting, typesetting, and review of the resulting proof before it is published in its final form. Please note that during the production process errors may be discovered which could affect the content, and all legal disclaimers that apply to the journal pertain.

Thermal stability of nanoscale metallic multilayers

A. S. Ramos¹, A. J. Cavaleiro¹, M. T. Vieira¹, J. Morgiel², G. Safran³

¹CEMUC®, Departamento de Engenharia Mecânica, Universidade de Coimbra,

3030-788 Coimbra, Portugal

²Institute of Metallurgy and Materials Science, Polish Academy of Sciences,

Reymonta 25, 30-059 Cracow, Poland

³Research Institute for Technical Physics and Materials Science, Hungarian

Academy of Sciences, H-1121 Budapest, Hungary

Abstract

Metallic nanolayered thin films/foils, in particular Ni/Al multilayers, have been used to

promote joining. The objective of this work is to evaluate the thermal stability of

nanoscale metallic multilayers with potential for joining applications. Multilayers thin

films with low (Ti/Al and Ni/Ti), medium (Ni/Al) and high (Pd/Al) enthalpies of

exothermic reaction were prepared by dual cathode magnetron sputtering. Their

thermal stability was studied by: i) differential scanning calorimetry combined with X-

ray diffraction (XRD), ii) in-situ XRD using cobalt radiation, and iii) in-situ

transmission electron microscopy. It was possible to detect traces of intermetallic or

amorphous phases in the as-deposited short period (bilayer thickness) multilayers,

¹ Corresponding author

E-mail address: sofia.ramos@dem.uc.pt

Departamento de Engenharia Mecânica

Pólo II, Universidade de Coimbra

R. Luís Reis Santos

3030 Coimbra, Portugal

Tel.: + 351 239790700; fax: + 351 239790701

1

Download English Version:

https://daneshyari.com/en/article/10669732

Download Persian Version:

https://daneshyari.com/article/10669732

Daneshyari.com